

| Ref # | Hits | Search Query | DBs | Default Operator | Plurals | Time Stamp |
|-------|-------|---|---|------------------|---------|------------------|
| L1 | 38626 | crack and (integrat\$3 adj circuit or semiconductor) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/01/19 21:50 |
| L2 | 81 | l1 and crack adj stop | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/01/19 21:43 |
| L3 | 6 | l2 and release | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/01/19 21:50 |
| L4 | 28 | (crack adj stop).CLM. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/01/19 21:51 |
| L5 | 8 | ((("6091131") or ("6174814") or ("6261945") or ("6492247")),PN. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/01/19 21:53 |